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FORM PTO-1449	ATTY. DKT NO.	11-219	SER. NO.	10/765,882
	APPLICANT	OONISHI		
	FILING DATE	January 29, 2004	GROUP	2632



REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
EB	5,633,461	02/27/97	Kakizaki et al.		

FOREIGN PATENT DOCUMENTS

TRANSLATION										
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract
EO	1	WO 92/20096	11/12/92	PCT				X		
EO	1	EP 0 261 555	03/30/88	Europe				X		
		DE 195 03 778	08/08/96	Germany					X	

- * Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
	8/18/05